

<b>Notice of References Cited</b>	Application/Control No. 10/714,634	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner HADI AKHAVANNIK	Art Unit 2624	Page 1 of 1

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*	B US-6,744,916	06-2004	Takahashi, Sadao	382/162
	C US-			
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**NON-PATENT DOCUMENTS**

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